

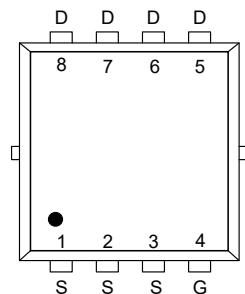
## SSC8L61GN4

P-Channel Enhancement Mode MOSFET

### ➤ Features

<b>V<sub>DS</sub></b>	<b>V<sub>GS</sub></b>	<b>R<sub>DSON</sub>(Typ.)</b>	<b>I<sub>D</sub></b>
<b>-60V</b>	<b>±20V</b>	19mΩ@-10V	<b>-37A</b>
		25mΩ@-4.5V	

### ➤ Pin Configuration



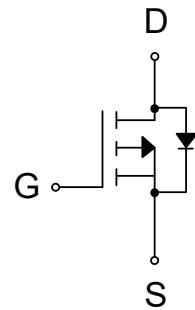
### ➤ Description

This device is P-Channel enhancement MOSFET.

Uses SGT technology and design to provide excellent RDS<sub>ON</sub> with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit.

**100% UIS + ΔVDS + Rg Tested!**

PDFN3.3X3.3-8L (Top View)



### ➤ Applications

- Load Switch
- PWM Application
- Power Management

Pin Configuration

### ➤ Ordering Information

Device	Package	Shipping
SSC8L61GN4	PDFN3.3X3.3-8L	5000/Reel



Marking

(XXYY: Internal Traceability Code)

➤ Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Ratings	Unit
$V_{DSS}$	Drain-to-Source Voltage	-60	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 20$	V
$I_D$	Continuous Drain Current <sup>d</sup>	$T_C=25^\circ\text{C}$	-37
		$T_C=100^\circ\text{C}$	-23
$I_{DSM}$	Continuous Drain Current <sup>a</sup>	$T_A=25^\circ\text{C}$	-7.6
		$T_A=70^\circ\text{C}$	-4.8
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	-148	A
$P_D$	Power Dissipation <sup>c</sup>	$T_C=25^\circ\text{C}$	56
		$T_C=100^\circ\text{C}$	24
$P_{DSM}$	Power Dissipation <sup>a</sup>	$T_A=25^\circ\text{C}$	2.5
		$T_A=70^\circ\text{C}$	1.0
$I_{AS}$	Avalanche Current <sup>b</sup> L=0.5mH Single Pulse	-22	A
$E_{AS}$	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse	121	mJ
$T_J$	Operation junction temperature	-55~150	$^\circ\text{C}$
$T_{STG}$	Storage temperature range	-55~150	

➤ Thermal Resistance Ratings ( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Ratings	Max.	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>a</sup>	50	60	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case Thermal Resistance	2.1	2.5	

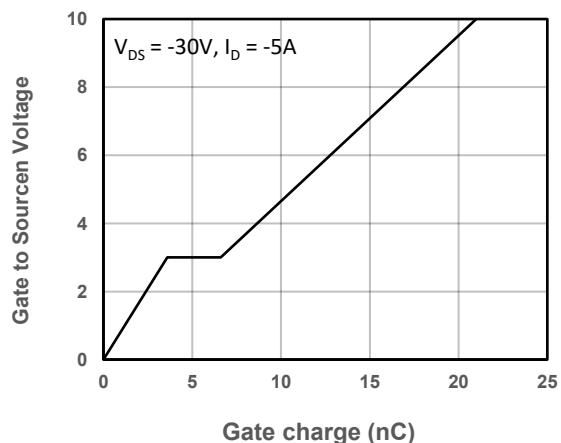
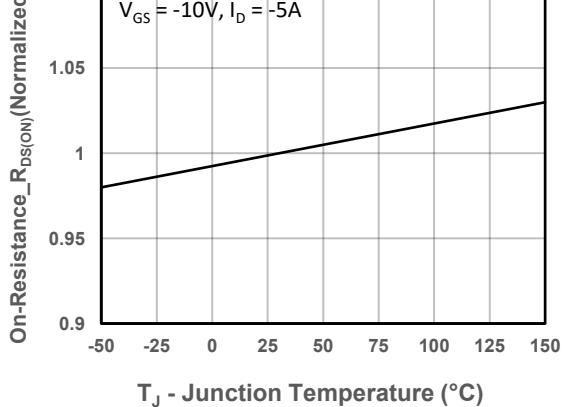
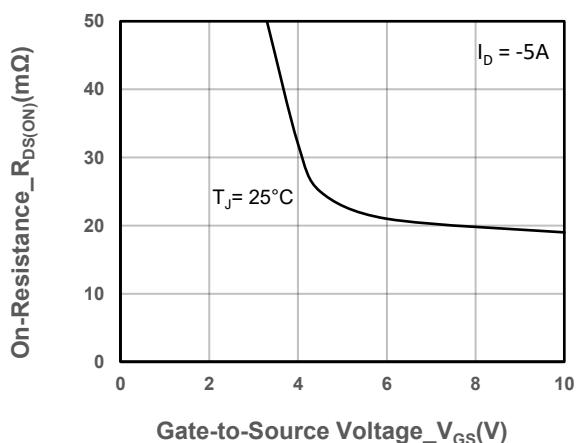
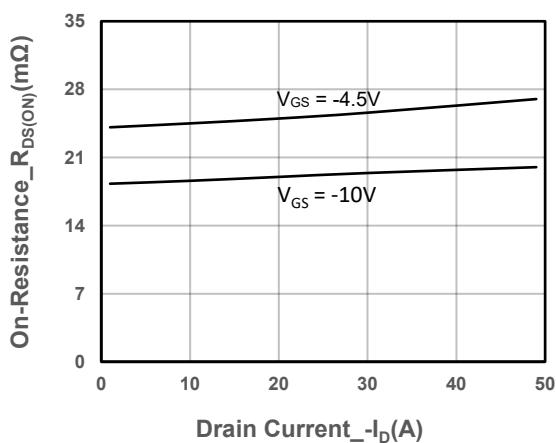
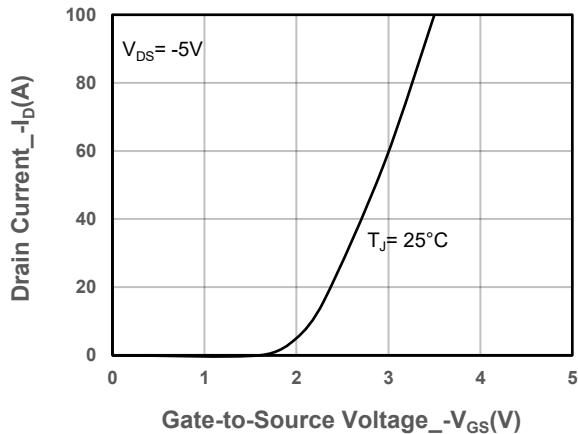
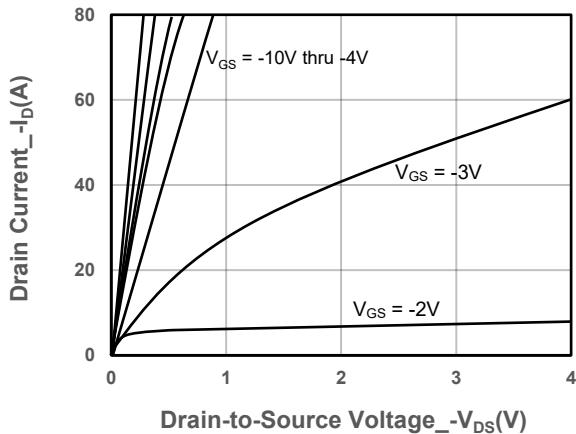
Note:

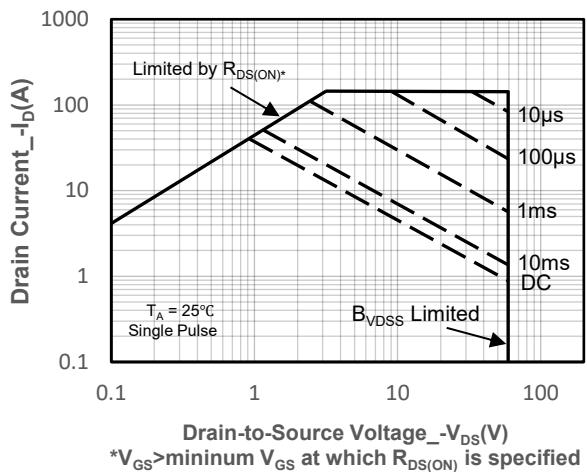
- a. The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The power dissipation is based on the  $t \leq 10\text{s}$  thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

➤ Electrical Characteristics ( $T_A=25^\circ C$  unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-60			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.6	-2.5	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -6A$		19	27	$m\Omega$
		$V_{GS} = -4.5V, I_D = -3A$		25	36	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -60V, V_{GS} = 0V$			-1	$\mu A$
Gate-Source Leak Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
Forward Voltage	$V_{SD}$	$V_{GS} = 0V, I_S = -1A$		-0.71	-1.3	V
Gate Resistance	$R_G$	$V_{DS} = 0V, f = 1MHz$		7.5		$\Omega$
Input Capacitance	$C_{iss}$	$V_{DS} = -30V, V_{GS} = 0V,$ $f = 1MHz$		1500		$pF$
Output Capacitance	$C_{oss}$			250		
Reverse Transfer Capacitance	$C_{rss}$			12		
Total Gate Charge	$Q_G$	$V_{GS} = -10V, V_{DS} = -30V,$ $I_D = -5A$		21		$nC$
Gate to Source Charge	$Q_{GS}$			3.6		
Gate to Drain Charge	$Q_{GD}$			3		
Turn-on Delay Time	$T_{D(ON)}$	$V_{GS} = -10V, V_{DS} = -30V,$ $I_D = -5A, R_G = 3\Omega$		16		$ns$
Rise Time	$T_r$			18		
Turn-off Delay Time	$T_{D(OFF)}$			40		
Fall Time	$T_f$			45		
Diode Recovery Time	$T_{rr}$	$I_F = -20A, di/dt = 500A/us$		37		ns
Diode Recovery Charge	$Q_{rr}$	$I_F = -20A, di/dt = 500A/us$		50		$nC$

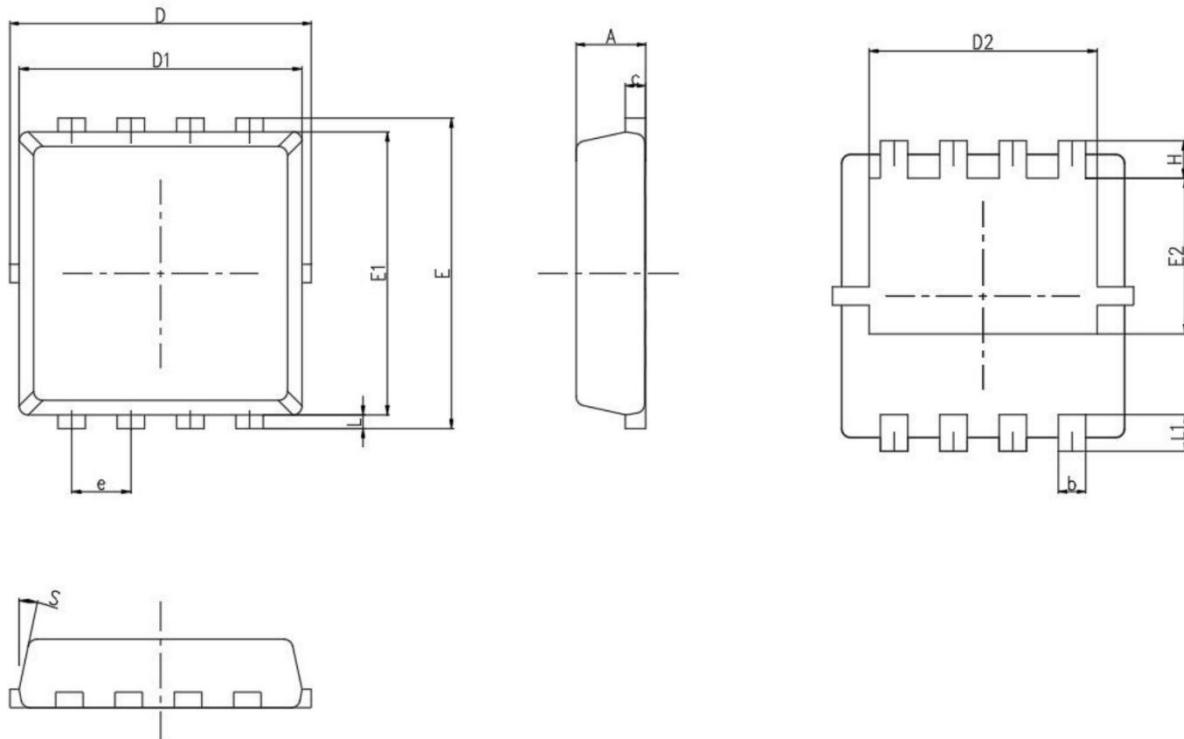
➤ Typical Performance Characteristics ( $T_A=25^\circ\text{C}$  unless otherwise noted)





### Safe Operating Area vs. Junction-to-Ambient

➤ Package Information



Symbol	MILL IMETER		
	Min	Nom	Max
A	0.65	0.75	0.9
b	0.20	0.3	0.40
c	0.1	/	0.22
D	3.1	3.3	3.45
D1	3	3.15	3.2
D2	2.55	2.5	2.75
E	3.15	3.3	3.45
E1	2.9	3.05	3.2
E2	1.55	1.75	1.95
e	0.65BSC		
L	0.06	0.15	0.2
L1	0.25	0.4	0.55
H	0.31	0.35	0.6
S	10°	12°	14°

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